I hereby certify that this correspondence is being deposited with the United States Postal Service, with sufficient postage, as first class mail in an envelope addressed to:

Assistant Commissioner for Patents

Washington, D.C. 20231

on March 31, 2000

Date of Deposit

Paul E. Rauch, Ph.D.

Name of applicant, assignee or

Resistered Representative

Signature March 31, 2000 Date of Signature # Par Andla

Our Case No. 10200/12

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Nulty et al.

Filing Date: Filed herewith

For METHOD FOR ELIMINATING
LATERAL SPACER EROSION ON
ENCLOSED CONTACT
TOPOGRAPHIES DURING RF
SPUTTER CLEANING

## PRELIMINARY AMENDMENT

Assistant Commissioner for Patents Washington, D.C. 20231

Dear Sir:

Prior to examination on the merits, please amend the above-identified application as follows:



#### IN THE TITLE

Please replace the title with the following: --STRUCTURE HAVING REDUCED LATERAL SPACER EROSION--.

# IN THE CLAIMS

Please amend the claims as follows:

Please cancel Claims 1-24, without prejudice to their further prosecution in a Divisional and/or Continuation application.

Claims 25-26, line 2 of each, please change "is" to --comprises--.

Please add the following new claims:

27. A structure, comprising:

(a) a conductive layer disposed over a substrate;

(b) a first insulating layer on the conductive layer;

(c) a contact region in said first insulating layer;

(d) at least one insulating spacer in the contact region adjacent to the

first insulating layer; and

(e) an etch stop material over said first insulating layer and adjacent to the insulating spacer, the etch stop material being distinct from the insulating spacer.

28. The structure of taim 27, wherein the insulating spacer has a substantially rectangular profile in the contact region.

29. The structure of Claim 27, wherein the insulating spacer has a surface portion in the contact region without overlying etch stop material.

- 30. The structure of Claim 29, wherein the insulating spacer surface portion without overlying etch stop material comprises an insulating spacer surface portion most distant from said substrate.
- 31. The structure of Chaim 28, wherein the insulating spacer has a surface portion in the contact region without overlying etch stop material.



Coffi

The structure of Claim 27, further comprising a second insulating layer on the etch stop layer and over the conductive layer.

33. The structure of Claim 32, further comprising a second conductive material in the contact region.

34. A structure, comprising the steps of:

- (a) a first electrically conductive material formed in and/or on a surface of a substrate;
- (b) a contact opening in a region adjacent to a second electrically conductive material formed on the substrate;
- (c) an electrically insulative spacer in the contact opening adjacent to the second electrically conductive material;
- (d) an etch stop layer over the electrically insulative spacer and the first and second electrically conductive regions;
  - (e) a blanket layer over the etch stop layer; and
- (f) an opening through a first part of the etch stop layer to the first electrically conductive region.
- The structure of Claim 34, wherein the electrically insulative spacer has a substantially rectangular cross-sectional shape in a plane that is substantially perpendicular to the substrate surface.
- 36. The atructure of Claim 34, wherein the electrically insulating spacer has a surface portion without overlying etch stop material.
  - 37. The structure of Claim 36, wherein the electrically insulating spacer surface portion without overlying etch stop material comprises a surface portion most distant from said substrate.
  - 38. The structure of Claim 34, further comprising a second insulating layer on the etch stop layer and over the conductive layer.



material in the contact region.

## **REMARKS**

Applicants submit the application is now in condition for examination on the merits. Early notice of such action is earnestly solicited.

Respectfully submitted,

Paul E. Rauch, Ph.D. Registration No. 38,591 Attorney for Applicant

BRINKS HOFER GILSON & LIONE P.O. BOX 10395 CHICAGO, ILLINOIS 60610 (312) 321-4200

F:\Home\Prauch\10200 Cypress\ 10200 12 - Preliminary Amendment

